STN

Nespájkované spoje Časť 7: Spoje s pružinovým upnutím Všeobecné požiadavky, skúšobné metódy a praktické pokyny

STN EN IEC 60352-7

35 4061

Solderless connections - Part 7: Spring clamp connections - General requirements, test methods and practical guidance

Táto norma obsahuje anglickú verziu európskej normy. This standard includes the English version of the European Standard.

Táto norma bola oznámená vo Vestníku ÚNMS SR č. 04/21

Obsahuje: EN IEC 60352-7:2021, IEC 60352-7:2020

Oznámením tejto normy sa od 20.01.2024 ruší STN EN 60352-7 (35 4061) z apríla 2003

EUROPEAN STANDARD NORME EUROPÉENNE EUROPÄISCHE NORM

EN IEC 60352-7

February 2021

ICS 31.220.10

Supersedes EN 60352-7:2002 and all of its amendments and corrigenda (if any)

English Version

Solderless connections - Part 7: Spring clamp connections - General requirements, test methods and practical guidance (IEC 60352-7:2020)

Connexions sans soudure - Partie 7: Connexions à ressort - Règles générales, méthodes d'essai et guide pratique (IEC 60352-7:2020) Lötfreie Verbindungen - Teil 7: Federklemmverbindungen -Allgemeine Anforderungen, Prüfverfahren und Anwendungshinweise (IEC 60352-7:2020)

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European foreword

The text of document 48B/2823/CDV, future edition 2 of IEC 60352-7, prepared by SC 48B "Electrical connectors" of IEC/TC 48 "Electrical connectors and mechanical structures for electrical and electronic equipment" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 60352-7:2021.

The following dates are fixed:

- latest date by which the document has to be implemented at national (dop) 2021-10-20 level by publication of an identical national standard or by endorsement
- latest date by which the national standards conflicting with the (dow) 2024-01-20 document have to be withdrawn

This document supersedes EN 60352-7:2002 and all of its amendments and corrigenda (if any).

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The text of the International Standard IEC 60352-7:2020 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60512-1-100	NOTE	Harmonized as EN 60512-1-100
IEC 60512-9-5	NOTE	Harmonized as EN IEC 60512-9-5
IEC 60947-7-1:2009	NOTE	Harmonized as EN 60947-7-1:2009 (not modified)

Annex ZA

(normative)

Normative references to international publications with their corresponding European publications

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 Where an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	EN/HD	<u>Year</u>
IEC 60068-1	2013	Environmental testing - Part 1: General and guidance	EN 60068-1	2014
IEC 60189-3	2007	Low-frequency cables and wires with PVC insulation and PVC sheath - Part 3: Equipment wires with solid or stranded conductor wires, PVC insulated, in singles, pairs and triples	-	-
IEC 60228	2004	Conductors of insulated cables	EN 60228	2005
-	-		+ corrigendum May	2005
IEC 60512-1	-	Connectors for electrical and electronic equipment - Tests and measurements - Part 1: Generic specification		-
IEC 60512-1-1	-	Connectors for electronic equipment - Tests and measurements - Part 1-1: General examination - Test 1a: Visual examination	EN 60512-1-1	-
IEC 60512-1-2	-	Connectors for electronic equipment - Tests and measurements - Part 1-2: General examination - Test 1b: Examination of dimension and mass	EN 60512-1-2	-
IEC 60512-2-1	-	Connectors for electronic equipment - Tests and measurements - Part 2-1: Electrical continuity and contact resistance tests - Test 2a: Contact resistance - Millivolt level method	EN 60512-2-1	-
IEC 60512-2-2	-	Connectors for electronic equipment - Tests and measurements - Part 2-2: Electrical continuity and contact resistance tests - Test 2b: Contact resistance - Specified test current method	EN 60512-2-2	-

EN IEC 60352-7:2021 (E)

<u>Publication</u>	<u>Year</u>	<u>Title</u>	EN/HD	<u>Year</u>
IEC 60512-2-5	-	Connectors for electronic equipment - Tests and measurements - Part 2-5: Electrical continuity and contact resistance tests - Test 2e: Contact disturbance		-
IEC 60512-6-4	-	Connectors for electronic equipment - Tests and measurements - Part 6-4: Dynamic stress tests - Test 6d: Vibration (sinusoidal)		-
IEC 60512-9-2	-	Connectors for electronic equipment - Tests and measurements - Part 9-2: Endurance tests - Test 9b: Electrical load and temperature		-
IEC 60512-11-1	-	Connectors for electrical and electronic equipment - Tests and measurements - Part 11-1: Climatic tests - Test 11a - Climatic sequence		-
IEC 60512-11-4	-	Connectors for electronic equipment - Tests and measurements - Part 11-4: Climatic tests - Test 11d: Rapid change of temperature		-
IEC 60512-11-7	-	Connectors for electronic equipment - Tests and measurements - Part 11-7: Climatic tests - Test 11g: Flowing mixed gas corrosion test		-
IEC 60512-16-20	-	Electromechanical components for electronic equipment - Basic testing procedures and measuring methods - Part 16: Mechanical tests on contacts and terminations - Section 20: Test 16t: Mechanical strength (wired termination of solderless connections)		-



IEC 60352-7

Edition 2.0 2020-12

INTERNATIONAL STANDARD

Solderless connections -

Part 7: Spring clamp connections – General requirements, test methods and practical guidance





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67 000 electrotechnical terminology entries in English and French extracted from the Terms and Definitions clause of IEC publications issued since 2002. Some entries have been collected from earlier publications of IEC TC 37, 77, 86 and CISPR.



IEC 60352-7

Edition 2.0 2020-12

INTERNATIONAL STANDARD

Solderless connections -

Part 7: Spring clamp connections – General requirements, test methods and practical guidance

INTERNATIONAL ELECTROTECHNICAL COMMISSION

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CONTENTS

F	DREWO	PRD	4
IN	TRODU	JCTION	6
1	Scop	pe	7
2	Norm	native references	7
3	Term	ns and definitions	8
4	Reau	uirements	10
	4.1	Workmanship	
	4.2	Tools	
5	Pre-r	requisites for basic test schedule	
	5.1	Spring clamp terminations	
	5.1.1	. •	
	5.1.2		
	5.1.3	Design features	11
	5.1.4	Dimensions	11
	5.2	Wires	11
	5.2.1	General	11
	5.2.2	Materials	11
	5.2.3		
	5.2.4		
	5.2.5		
	5.3	Spring clamp connections	
6	Testi	ng	
	6.1	General	
	6.2	Standard conditions for testing	
	6.3	Preconditioning	
	6.4	Recovery	
7	6.5	Mounting of specimen	
7		s	
	7.1	General examination	
	7.2 7.2.1	Mechanical tests	
	7.2.1	š	
	7.2.2		
	7.2.3		
	7.3	Electrical tests	
	7.3.1		
	7.3.2		
	7.4	Climatic tests	
	7.4.1		
	7.4.2	Rapid change of temperature	19
	7.4.3	·	
	7.4.4	·	
8	Test	schedules	20
	8.1	General	20
	8.2	Basic test schedule	21

8.2.1 General	21
8.2.2 Initial examination	21
8.2.3 Testing of spring clamp connections with spring clamp terminations with and without a specified wire range	21
8.3 Full test schedule	22
8.3.1 General	22
8.3.2 Initial examination	22
8.3.3 Testing of spring clamp connections with and without a specified wire range	22
8.4 Flow charts	23
Annex A (informative) Practical guidance	26
A.1 Current-carrying capacity	26
A.2 Tool information	26
A.3 Termination information	
A.3.1 General	
A.3.2 Design features	
A.3.3 Materials	
A.3.4 Surface finishes	
A.4 Wire information	
A.4.1 General	
A.4.2 Materials	
A.4.4 Stripping information	
A.5 Connection information	
Bibliography	
Figure 1 – Examples of spring clamp connections	
Figure 2 – Example of a spring clamp terminal	
Figure 3 – Information for the wire deflection test	
Figure 4 – Test arrangement, vibration	17
Figure 5 – Test arrangement, current method	
Figure 6 – Basic test schedule (see 8.2)	24
Figure 7 – Full test schedule (see 8.3)	25
Figure A.1 – Correctly stripped wire	28
Figure A.2 – Examples of stripping faults	29
Table 1 – Values of tensile strength	13
Table 2 – Value of force for wire deflection test	15
Table 3 – Vibration, test severities	17
Table 4 – Rated current of the wires, initial and final contact resistance	19
Table 5 – Number of specimens required	21
Table 6 – Test group P1	
Table 7 – Test group P2	
Table 8 – Test group A	
Table 9 – Test group B	
Table 10 – Test group C	
Table 11 - Test group C	23

INTERNATIONAL ELECTROTECHNICAL COMMISSION

SOLDERLESS CONNECTIONS -

Part 7: Spring clamp connections – General requirements, test methods and practical guidance

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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International Standard IEC 60352-7 has been prepared by subcommittee SC 48B: Electrical connectors, of IEC technical committee 48: Electrical connectors and mechanical structures for electrical and electronic equipment.

This second edition cancels and replaces the first edition of IEC 60352-7, published in 2002. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) correction of the two flow charts in Figure 6 and Figure 7,
- b) split the content into more clauses for better separation between full test schedule and basic test schedule,
- c) relocating the content of former Clause 6 Practical guidance into an informative Annex A, as now common in the IEC 60352 series for solderless connections,

- 5 -

d) clarification on conductor types with reference to classes defined in IEC 60228.

The text of this International Standard is based on the following documents:

FDIS	Report on voting
48B/2823/CDV	48B/2851/RVC

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

This document was drafted in accordance with ISO/IEC Directives, Part 2.

A list of all parts in the IEC 60352 series, published under the general title *Solderless* connections, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific document. At this date, the document will be

- · reconfirmed,
- · withdrawn,
- · replaced by a revised edition, or
- · amended.

- 6 -

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INTRODUCTION

This part of IEC 60352 covers spring clamp connections and includes requirements, tests and practical guidance information.

Two test schedules are provided.

- a) The basic test schedule applies to spring clamp connections which conform to all requirements of Clause 5. These requirements are derived from experience with successful applications of such spring clamp connections.
- b) The full test schedule applies to spring clamp connections which do not fully conform to all requirements of Clause 5, for example which are manufactured using materials or finishes not included in Clause 5.

This approach permits cost and time effective performance verification using a limited basic test schedule for established spring clamp connections and an expanded full test schedule for spring clamp connections requiring more extensive performance validation.

The values given in this document are minimum values, which are harmonized with other IEC documents. Other standards may specify other values.

-7-

SOLDERLESS CONNECTIONS -

Part 7: Spring clamp connections – General requirements, test methods and practical guidance

1 Scope

This part of IEC 60352 is applicable to spring clamp connections made with stripped wire without further preparation:

- solid conductors of 0,32 mm to 3,7 mm nominal diameter (0,08 mm² to 10 mm² cross-section), or
- stranded conductors of 0,08 mm² to 10 mm² cross-section, or
- flexible conductors of 0,08 mm² to 10 mm² cross-section,

according to IEC 60228 or IEC 60189-3 for use in electrical and electronic equipment and components.

Information on materials and data from industrial experience is included in addition to the test procedures to provide electrically stable connections under prescribed environmental conditions.

The object of this document is to determine the suitability of spring clamp connections under specified mechanical, electrical and atmospheric conditions.

NOTE IEC Guide 109 advocates the need to minimize the impact of a product on the natural environment throughout the product life cycle. It is understood that some of the materials permitted in this document can have a negative environmental impact. As technological advances lead to acceptable alternatives for these materials, they will be eliminated from this document.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60068-1:2013, Environmental testing – Part 1: General and guidance

IEC 60189-3:2007, Low-frequency cables and wires with PVC insulation and PVC sheath – Part 3: Equipment wires with solid or stranded conductor wires, PVC insulated, in singles, pairs and triples

IEC 60228:2004, Conductors of insulated cables

IEC 60512-1, Connectors for electrical and electronic equipment – Tests and measurements – Part 1: Generic specification

IEC 60512-1-1, Connectors for electronic equipment – Tests and measurements – Part 1-1: General examination – Test 1a: Visual examination

IEC 60512-1-2, Connectors for electronic equipment – Tests and measurements – Part 1-2: General examination – Test 1b: Examination of dimension and mass

IEC 60512-2-1, Connectors for electronic equipment – Tests and measurements – Part 2-1: Electrical continuity and contact resistance tests – Test 2a: Contact resistance – Millivolt level method

IEC 60512-2-2, Connectors for electronic equipment – Tests and measurements – Part 2-2: Electrical continuity and contact resistance tests – Test 2b: Contact resistance – Specified test current method

IEC 60512-2-5, Connectors for electronic equipment – Tests and measurements – Part 2-5: Electrical continuity and contact resistance tests – Test 2e: Contact disturbance

IEC 60512-6-4, Connectors for electronic equipment – Tests and measurements – Part 6-4: Dynamic stress tests – Test 6d: Vibration (sinusoidal)

IEC 60512-9-2, Connectors for electronic equipment – Tests and measurements – Part 9-2: Endurance tests – Test 9b: Electrical load and temperature

IEC 60512-11-1, Connectors for electrical and electronic equipment – Tests and measurements – Part 11-1: Climatic tests – Test 11a – Climatic sequence

IEC 60512-11-4, Connectors for electronic equipment – Tests and measurements – Part 11-4: Climatic tests – Test 11d: Rapid change of temperature

IEC 60512-11-7, Connectors for electronic equipment – Tests and measurements – Part 11-7: Climatic tests – Test 11g: Flowing mixed gas corrosion test

IEC 60512-16-20, Electromechanical components for electronic equipment – Basic testing procedures and measuring methods – Part 16: Mechanical tests on contacts and terminations – Section 20: Test 16t: Mechanical strength (wired termination of solderless connections)

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